

#### 20V DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

## **Product Summary**

V <sub>(BR)DSS</sub>	Max R <sub>DS(on)</sub>	I <sub>D</sub> max T <sub>A</sub> = 25°C (Notes 6)
20V	195mΩ @ V <sub>GS</sub> = 4.5V	2.11A
	260mΩ @ V <sub>GS</sub> = 2.5V	1.83A
	380mΩ @ V <sub>GS</sub> = 1.8V	1.51A
	520mΩ @ V <sub>GS</sub> = 1.5V	1.29A

### **Description and Applications**

This MOSFET has been designed to minimize the on-state resistance (R<sub>DS(on)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Load switch

#### **Features and Benefits**

- Footprint of just 1.3 mm<sup>2</sup>
- Ultra Low Profile Package 0.4mm profile
- On resistance <200mΩ</li>
- Low Gate Threshold Voltage
- Fast Switching Speed
- Ultra-Small Surface Mount Package
- ESD Protected Gate 2KV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

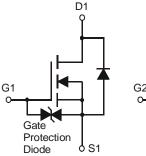
#### **Mechanical Data**

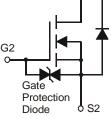
Case: X2-DFN1310-6

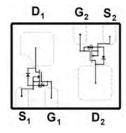
D2

- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 <a href="#equation-of-8">●</a>









Top View Pin-Out

### **Ordering Information** (Note 4)

ĺ	Part Number	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
	DMN2300UFL4-7	23N	7	8	3000

Device Symbol

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

### **Marking Information**



23N = Product Type Marking Code



### Maximum Ratings @TA = 25°C unless otherwise specified

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V <sub>DSS</sub>	20	V
Gate-Source Voltage			V <sub>GSS</sub>	±8	V
Continuous Drain Current (Note 6) Steady $T_A = 25^{\circ}C$ State $T_A = 85^{\circ}C$		I <sub>D</sub>	2.11 1.19	А	
Pulsed Drain Current (Note 7)			I <sub>DM</sub>	6.0	А

## Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit		
Power Dissipation	(Note 5)	ь	0.53	- W	
Power Dissipation	(Note 6)	P <sub>D</sub>	1.39		
Thermal Desistance Investigate Ambient	(Note 5)	<b>D</b>	238	°C/W	
Thermal Resistance, Junction to Ambient	(Note 6)	$R_{\theta JA}$	90		
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout;
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate
- 7. Device mounted on minimum recommended pad layout test board, 10µs pulse duty cycle = 1%.

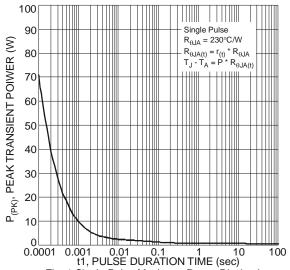
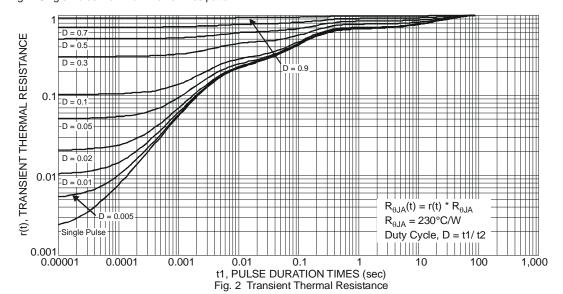


Fig. 1 Single Pulse Maximum Power Dissipation

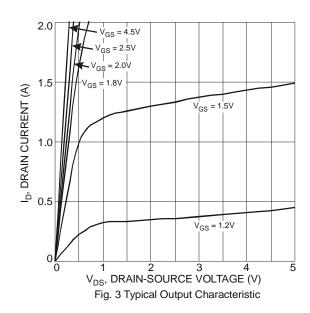


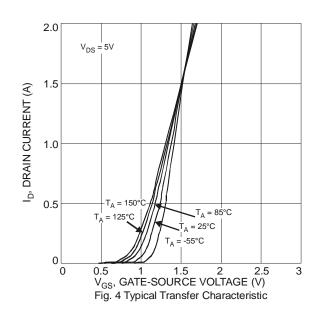


## Electrical Characteristics @T<sub>A</sub> = 25°C unless otherwise specified

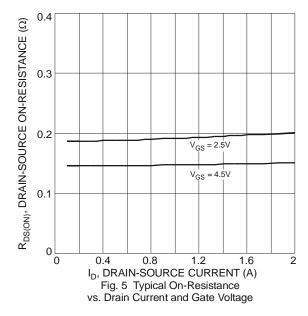
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	20	-	-	V	$V_{GS} = 0V, I_{D} = 10\mu A$	
Zero Gate Voltage Drain Current T <sub>J</sub> = 25°C	I <sub>DSS</sub>	-	-	1	μΑ	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	-	-	10	μΑ	$V_{GS} = \pm 8V$ , $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)				-			
Gate Threshold Voltage	$V_{GS(th)}$	0.45	1	0.95	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
	-	-	-	195	mΩ	$V_{GS} = 4.5V, I_D = 300mA$	
Static Drain-Source On-Resistance		-	-	260		$V_{GS} = 2.5V, I_D = 250mA$	
Static Drain-Source On-Resistance	R <sub>DS (ON)</sub>			380		$V_{GS} = 1.8V, I_D = 100mA$	
		-	-	520		V <sub>GS</sub> = 1.5V, I <sub>D</sub> = 50mA	
Forward Transfer Admittance	Y <sub>fs</sub>	40	-	-	mS	$V_{DS} = 3V, I_{D} = 30mA$	
Diode Forward Voltage	V <sub>SD</sub>	-	0.7	1.2	V	$V_{GS} = 0V, I_S = 300mA$	
DYNAMIC CHARACTERISTICS	_						
Input Capacitance	C <sub>iss</sub>	-	64.3	-	pF	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V, f = 1.0MHz	
Output Capacitance	Coss	-	6.1	-	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	4.5	-	pF	T = 1.0IVID2	
Gate Resistance	Rg	-	70	-	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge	Qg	-	1.6	-	nC	45)/ 45)/	
Gate-Source Charge	Q <sub>qs</sub>	-	0.2	-	nC	$V_{GS} = 4.5V, V_{DS} = 15V,$	
Gate-Drain Charge	Q <sub>gd</sub>	-	0.2	-	nC	I <sub>D</sub> = 1A	
Turn-On Delay Time	t <sub>D(on)</sub>	-	3.5	-	ns	V <sub>DS</sub> = 10V, I <sub>D</sub> = 1A	
Turn-On Rise Time	t <sub>r</sub>	-	2.8	-	ns		
Turn-Off Delay Time	t <sub>D(off)</sub>	-	38	-	ns	$V_{GS} = 10V, R_G = 6\Omega$	
Turn-Off Fall Time	t <sub>f</sub>	-	13	-	ns		

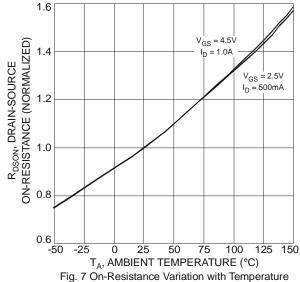
Notes: 8. Short duration pulse test used to minimize self-heating effect.











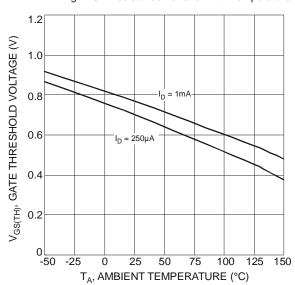
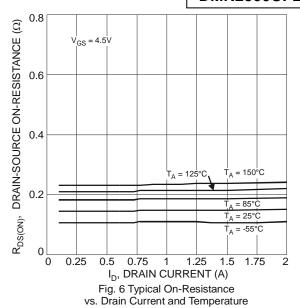
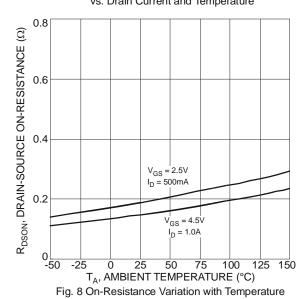
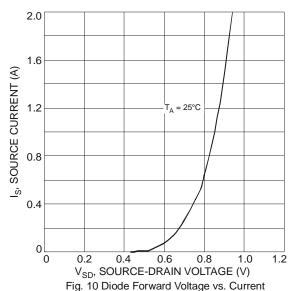


Fig. 9 Gate Threshold Variation vs. Ambient Temperature



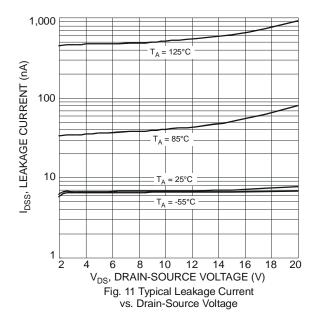


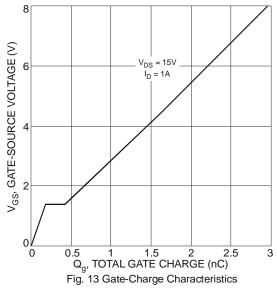


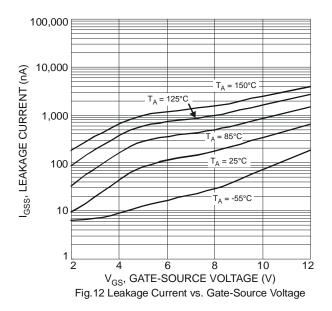


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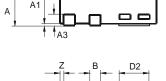


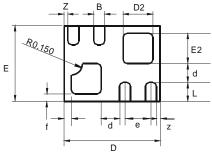






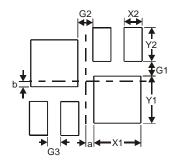
# **Package Outline Dimensions**





X2-DFN1310-6					
Dim	Min	Max	Тур		
Α	_	0.40	_		
A1	0	0.05	0.02		
А3	_		0.13		
b	0.10	0.20	0.15		
D	1.25	1.38	1.30		
d			0.25		
D2	0.30	0.50	0.40		
Е	0.95	1.075	1.00		
е			0.35		
E2	0.30	0.50	0.40		
f	_	_	0.10		
L	0.20	0.30	0.25		
Z			0.05		
All Dimensions in mm					

# **Suggested Pad Layout**



Dimensions	Value (in mm)
G1	0.16
G2	0.17
G3	0.15
X1	0.52
X2	0.20
Y1	0.52
Y2	0.375
а	0.09
b	0.06





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